

Search Notes

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Applicant(s)/Patent under
Reexamination

HAUVILLE, FRANCOIS P.

Art Unit

1723

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	2/3/2006	YK
See EAST Search History 210/232,323.1,323.2,423,253,321.75	2/6/2006	YK